Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/714,390	TOVINKERE ET AL.	
Examiner	**Art Unit**	
Joon H. Hwang	2166	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Palm see search history printout(s)	7/1/2006	JH
Reviewed the parent App. 09/766,594 consulted 101 panel consulted Pat Salce for double patent consulted Alford Kindred	7/1/2006	JH